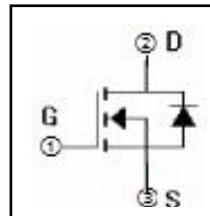


**D12N06M****12A 60V N-channel Enhancement Mode Power MOSFET****Description**

D12N06M is an N-channel enhancement mode power field-effect transistor. Using advanced trench technology design, providing excellent RDSON and low gate charge. The product can be used in a wide variety of application. The package form is TO-252. Which accords with the RoHS standard.



$V_{DSS} = 60V$
 $R_{DS(on)} \text{ (TYP)} = 0.056\Omega$
 $I_D = 12A$

Features

- Low On Resistance
- Low Gate Charge
- Fast Switching
- Low Reverse Transfer Capacitances
- 100% Single Pulse Avalanche Energy Test
- 100% ΔV_{DS} Test



TO-252

Applications:

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

Electrical Characteristics

Absolute Maximum Rating ($T_c=25^\circ C$, unless otherwise noted)

PARAMETER	SYMBOL	VALUE	UNIT
Maximum Drian-Source DC Voltage	V_{DSS}	60	V
Maximum Gate-Drain Voltage	V_{GSS}	± 20	V
Drain Current(continuous) ($T=25^\circ C$) ($T=100^\circ C$)	I_D	12	A
		8	A
Drain Current(Pulsed)(Note 1)	I_{DM}	36	A
Total Dissipation $T_a=25^\circ C$	P_{tot}	1.15	W
	P_{tot} $T_c=25^\circ C$	32.5	W
Junction Temperature	T_j	150	$^\circ C$
storage Temperature	T_{stg}	-55~150	$^\circ C$
High Temperature(tin solder)	T_L	300	$^\circ C$

Thermal Characteristics

PARAMETER	SYMBOL	VALUE	UNIT
Thermal Resistance Junction to Case-sink (Note 2)	R_{thJC}	3.85	$^\circ C/W$
Thermal Resistance Junction to Ambient (Note 2)	R_{thJA}	108.7	$^\circ C/W$

D12N06M

Electrical Characteristics (Tc=25°C, unless otherwise noted)

PARAMETER	SYMBOL	Test Condition	VALUE			UNIT
			MIN	TYP	MAX	
Off Characteristics						
Drain-source Breakdown Voltage	V _{DS}	I _D =250μA,V _{GS} =0V	60	--	--	V
Drain-to-Source Leakage Current	I _{DSS}	V _{DS} =60V,V _{GS} =0V,T _c =25°C	--	--	1	μA
		V _{DS} =48V,V _{GS} =0V,T _c =125°C	--	--	100	μA
Gate-to-Source Forward Leakage	I _{GSSF}	V _{GS} =20V,V _{DS} =0V	--	--	100	nA
Gate-to-Source Reverse Leakage	I _{GSSR}	V _{GS} =-20V,V _{DS} =0V	--	--	-100	nA
On Characteristics ^(Note 3)						
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250μA	1.0	1.3	2.0	V
Drain-source on Resistance	R _{DS(on)}	V _{GS} =10V,I _D =4A	--	56	80	mΩ
Dynamic Characteristics ^(Note 4)						
Forward Transfer conductance	g _{fs}	V _{DS} =15V,I _D =2A V _{GS} =0V,V _{DS} =30V,f=1.0MHz	--	3.0	--	s
Input Capacitance	C _{iss}		--	247	--	pF
Output Capacitance	C _{oss}		--	34	--	
Reverse Transfer Capacitance	C _{rss}		--	19.5	--	
Switching Characteristics ^(note4)						
Turn-on Delay Time	t _{d(on)}	I _D =1.5A, V _{DD} =30V, V _{GS} =10V, R _{GEN} =1Ω	--	6	--	nS
Turn-on Rise Time	t _r		--	15	--	nS
Turn-off Delay Time	t _{d(off)}		--	15	--	nS
Turn-off Fall Time	t _f		--	10	--	nS
Total Gate Charge	Q _g	I _D =3A,V _{DD} =30V,V _{GS} =4.5V	--	6	--	nC
Gate-to-Source Charge	Q _{gs}		--	1	--	
Gate-to-Drain("Miller")Charge	Q _{gd}		--	1.3	--	
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{FSD}	V _{GS} =0V,I _S =12A	--	--	1.2	V
Diode Forward Current (Note 2)	I _S		--	--	12	A

Notes:

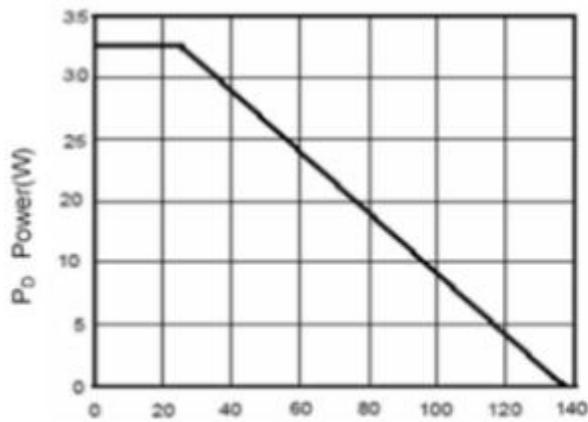
1: Repetitive rating, pulse width limited by maximum junction temperature.

2: Surface mounted on FR4 Board, t≤10sec.

3: Pulse width ≤ 300μs, duty cycle ≤ 2%.

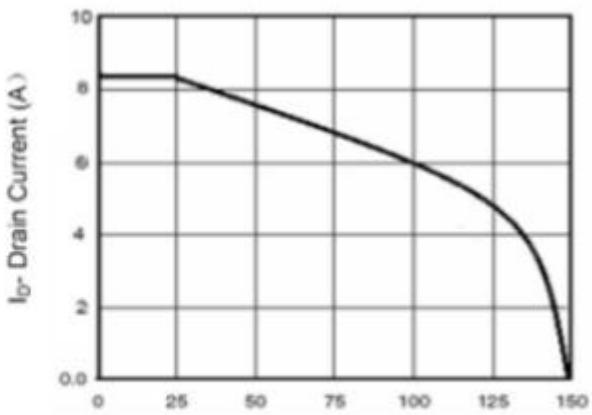
4: Guaranteed by design, not subject to production .

Typical characteristics diagrams



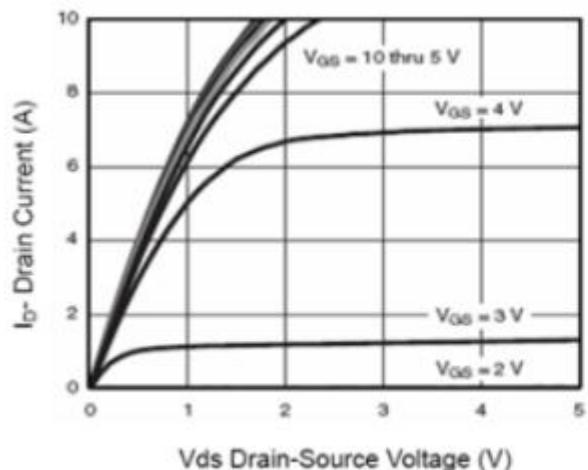
T_J-Junction Temperature(°C)

Figure 1 Power Dissipation



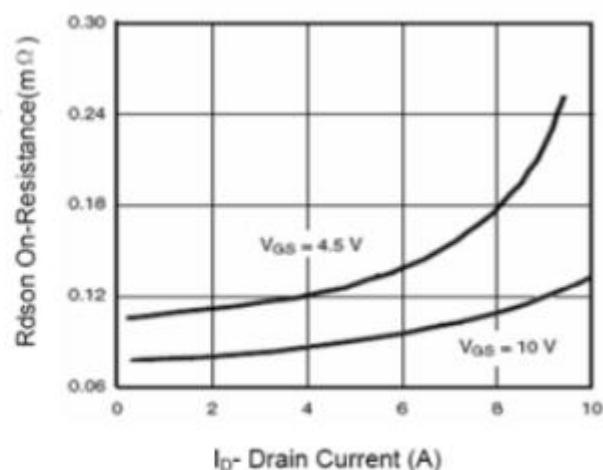
T_J-Junction Temperature(°C)

Figure 2 Drain Current



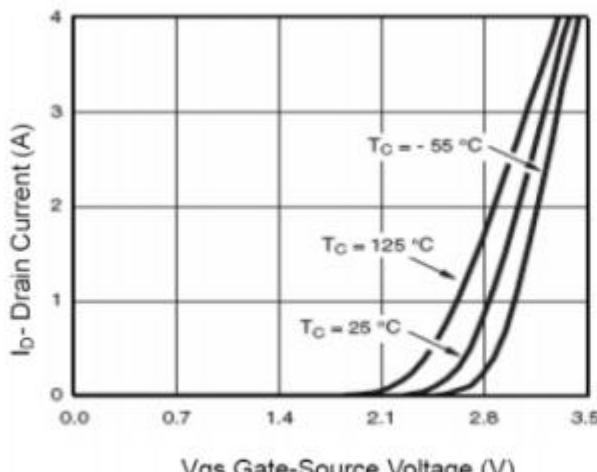
V_{DS}- Drain-Source Voltage (V)

Figure 3 Output Characteristics



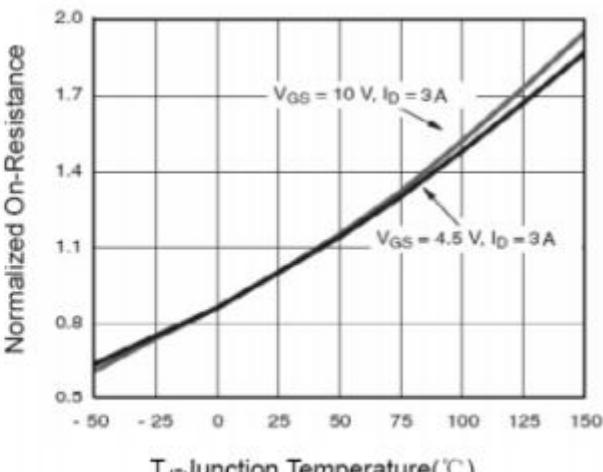
I_D- Drain Current (A)

Figure 4 Drain-Source On-Resistance



V_{GS}- Gate-Source Voltage (V)

Figure 5 Transfer Characteristics



T_J-Junction Temperature(°C)

Figure 6 Drain-Source On-Resistance

Typical characteristics diagrams(continues)

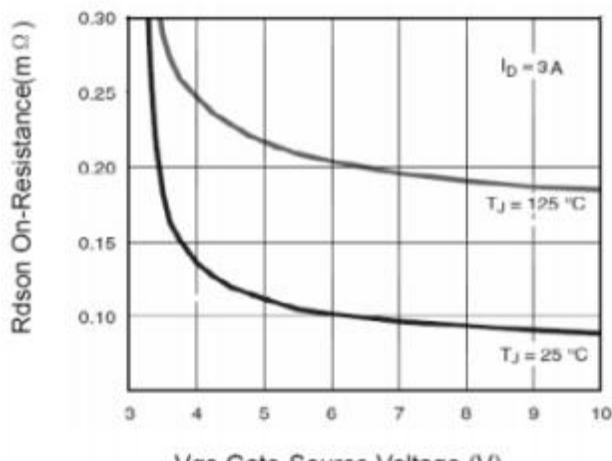


Figure 7 Rdson vs Vgs

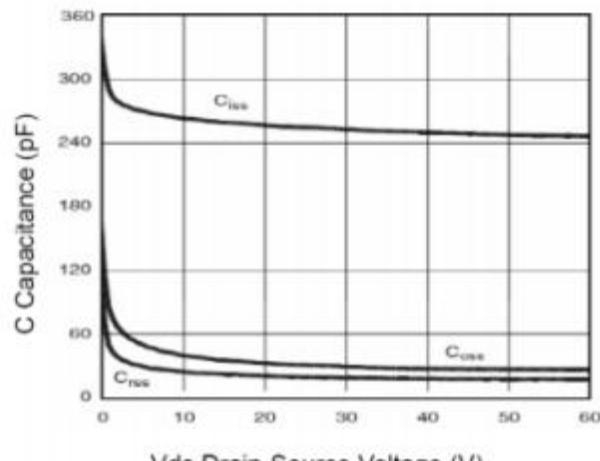


Figure 8 Capacitance vs Vds

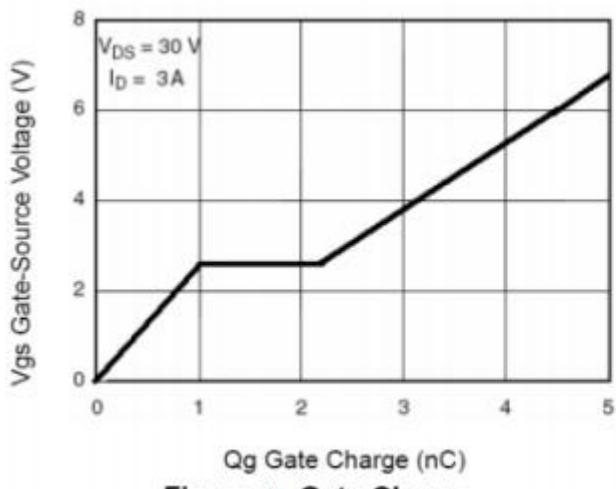


Figure 9 Gate Charge

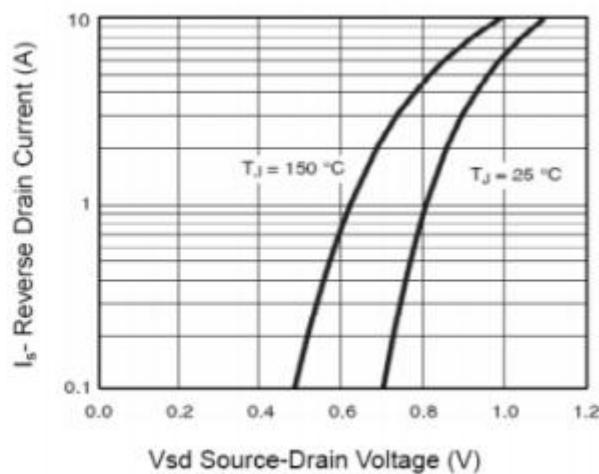


Figure 10 Source- Drain Diode Forward

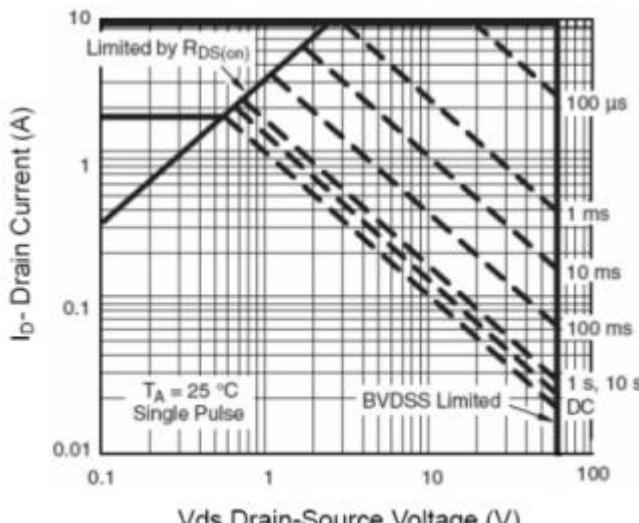
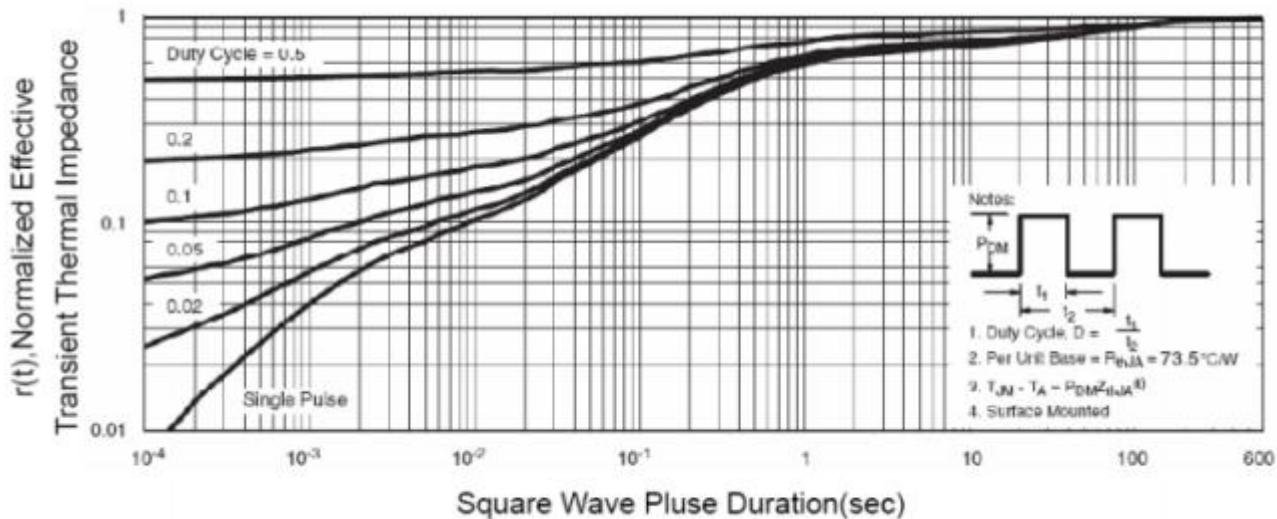
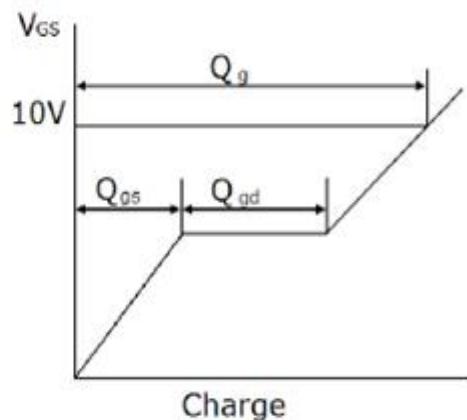
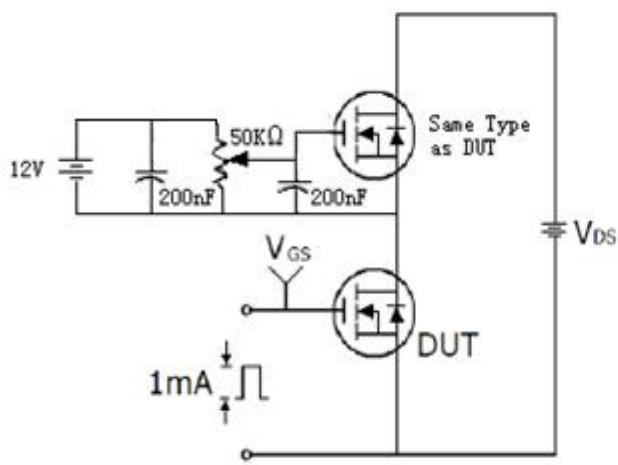


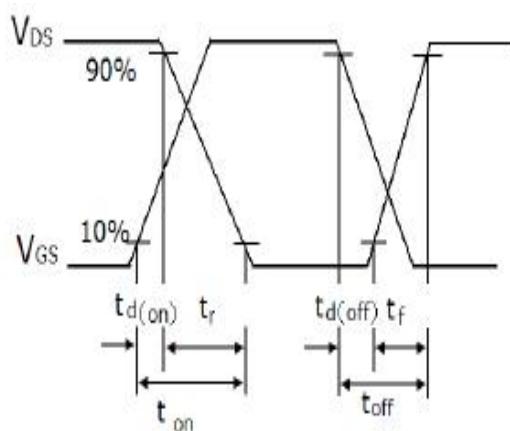
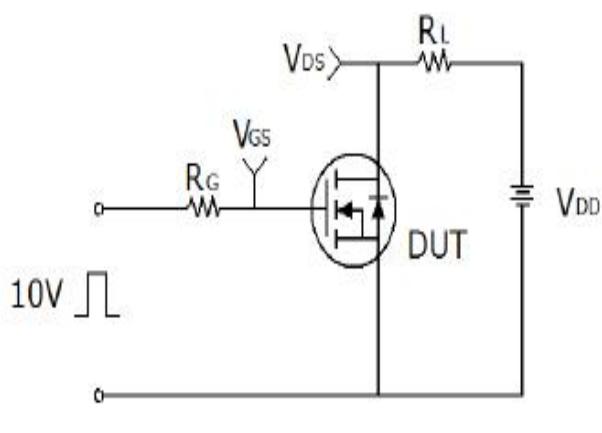
Figure 11 Safe Operation Area

Typical characteristics diagrams(continues)**Figure 12 Normalized Maximum Transient Thermal Impedance**

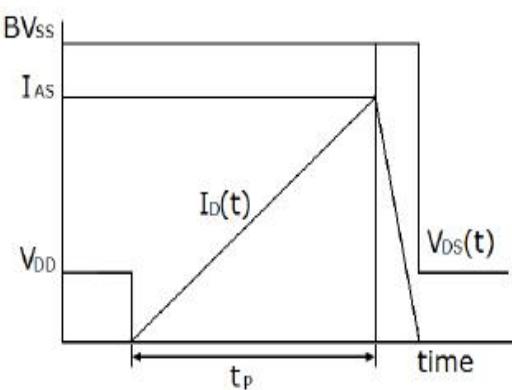
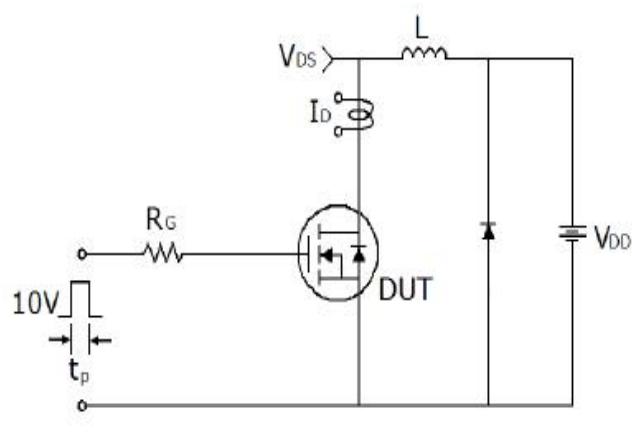
Typical Test Circuit and Waveform



1) Gate charge test circuit & Waveform

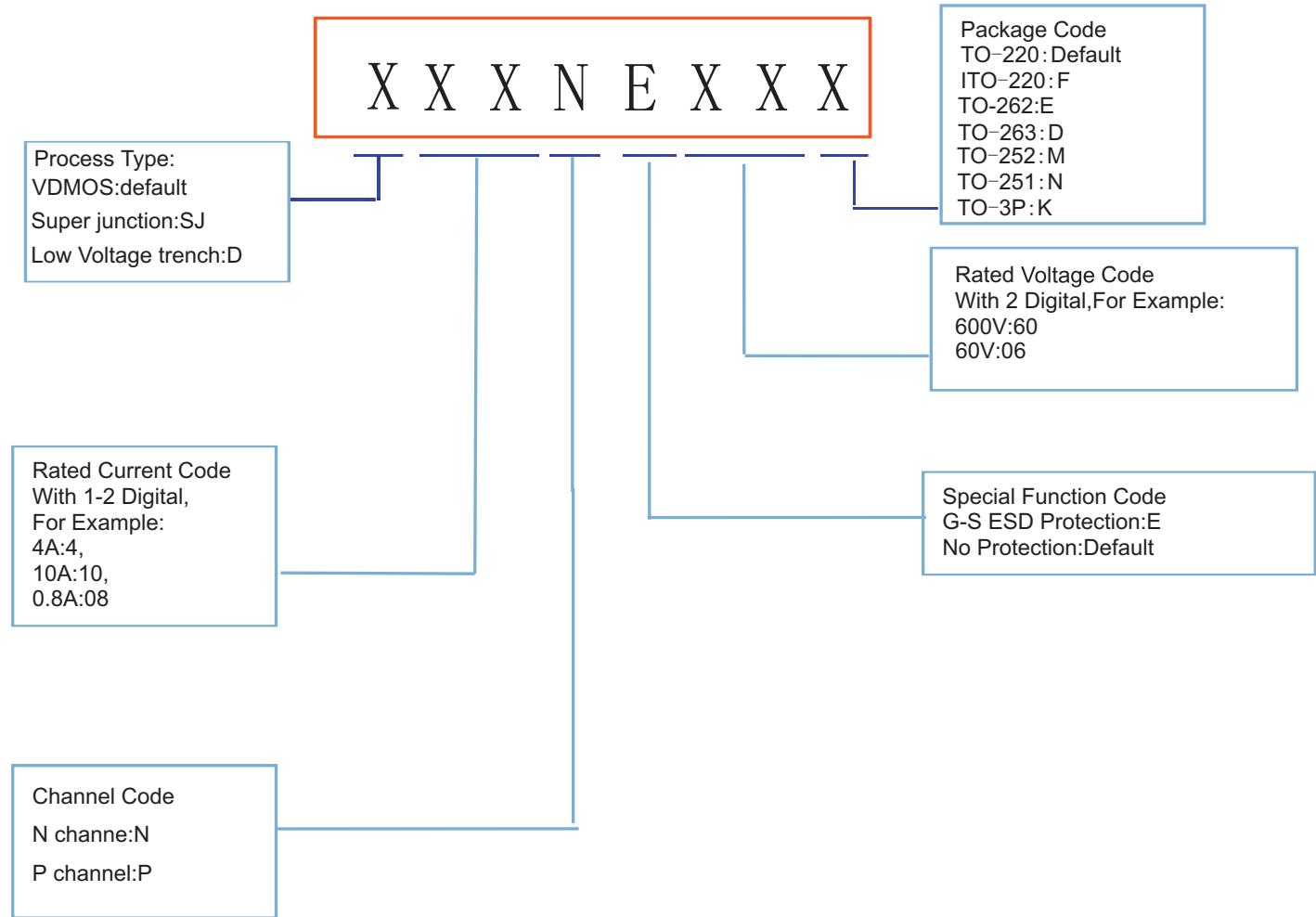


2) Switch Time Test Circuit:



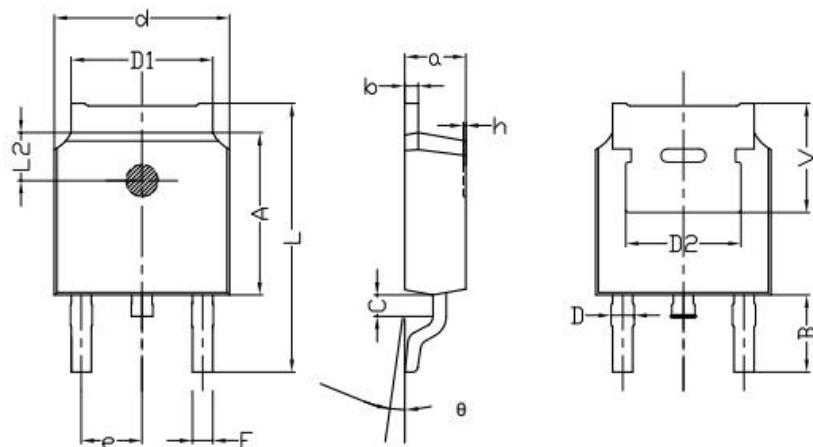
3) Unclamped Inductive Switching Test Circuit & Waveforms

Product Names Rules



Dimensions

TO-252 PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	min.	max.	min.	max.
a	2.20	2.40	0.087	0.095
b	0.46	0.58	0.018	0.023
c	0.70	0.90	0.028	0.035
D	0.80	1.00	0.032	0.039
d	6.30	6.70	0.248	0.264
D1	5.00	5.50	0.197	0.217
D2	TYP 4.83		TYP 0.190	
A	5.80	6.20	0.228	0.244
e	2.19	2.39	0.086	0.094
L	9.40	10.40	0.370	0.409
B	2.6	3.2	0.102	0.126
L2	1.5	1.8	0.059	0.071
θ	0	8	0	8
h	0	0.3	0	0.012
V	5.25	5.85	0.207	0.230